

Search Notes

Application/Control No.

10/686,117

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

SUGAYA ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	72A	2/18/2005	LEE
	100		
↓	117F		
439	404		
↓	395		
	443		
	405		
	67		
↓	422	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
N. Abrams	2/17/2005	LEE
East text search attached	2/18/2005	LEE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
174	as above	2/17/2005	LEE
439	as above	2/17/2005	Lee